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INTERNATIONAL STANDARD

Electronic displays – iTeh Standards
Part 3-6: Evaluation of optical performance – Spatial resolution
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INTERNATIONAL ELECTROTECHNICAL COMMISSION

ELECTRONIC DISPLAYS -

Part 3-6: Evaluation of optical performance – Spatial resolution

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IEC 62977-3-6 has been prepared by IEC technical committee 110: Electronic displays. It is an International Standard.

The text of this International Standard is based on the following documents:

Draft	Report on voting
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Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.